



## UTT60N10M

## POWER MOSFET

### 60A, 100V N-CHANNEL ENHANCEMENT MODE TRENCH POWER MOSFET

#### DESCRIPTION

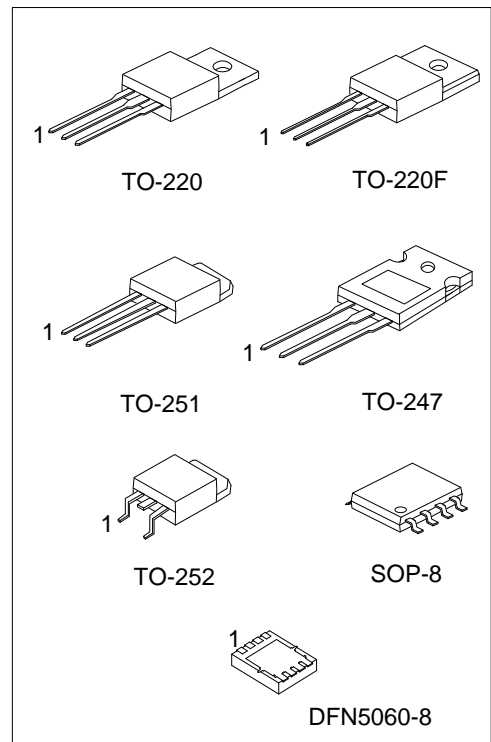
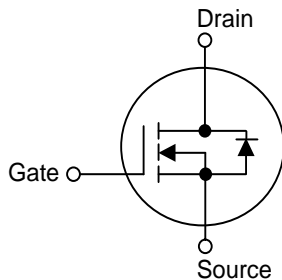
The UTC **UTT60N10M** is N-channel enhancement mode power MOSFET using UTC's advanced technology to provide customers with high switching speed, a extremely low  $R_{DS(ON)}$  and low gate charge.

The UTC **UTT60N10M** is suitable for high frequency Point -of-Load Synchronous, Networking DC-DC System, CCFL Back-light Inverter, etc.

#### FEATURES

- \*  $R_{DS(ON)} \leq 18 \text{ m}\Omega$  @  $V_{GS}=10\text{V}$ ,  $I_D=20\text{A}$
- \*  $R_{DS(ON)} \leq 25 \text{ m}\Omega$  @  $V_{GS}=4.5\text{V}$ ,  $I_D=15\text{A}$
- \* Green Device Available
- \* Low Gate Charge
- \* Surface mount package

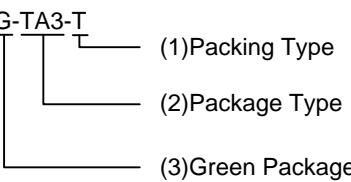
#### SYMBOL



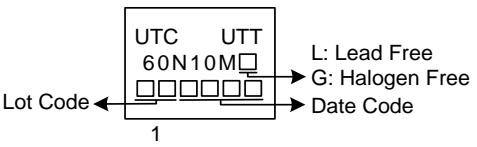
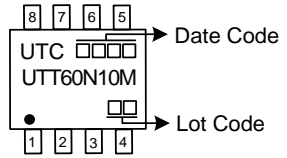
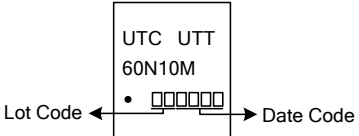
## ORDERING INFORMATION

Ordering Number		Package	Pin Assignment								Packing
Lead Free	Halogen Free		1	2	3	4	5	6	7	8	
UTT60N10ML-TA3-T	UTT60N10MG-TA3-T	TO-220	G	D	S	-	-	-	-	-	Tube
UTT60N10ML-TF3-T	UTT60N10MG-TF3-T	TO-220F	G	D	S	-	-	-	-	-	Tube
UTT60N10ML-TM3-T	UTT60N10MG-TM3-T	TO-251	G	D	S	-	-	-	-	-	Tube
UTT60N10ML-TN3-R	UTT60N10MG-TN3-R	TO-252	G	D	S	-	-	-	-	-	Tape Reel
UTT60N10ML-T47-T	UTT60N10MG-T47-T	TO-247	G	D	S	-	-	-	-	-	Tube
UTT60N10ML-S08-R	UTT60N10MG-S08-R	SOP-8	S	S	S	G	D	D	D	D	Tape Reel
UTT60N10ML-K08-5060-R	UTT60N10MG-K08-5060-R	DFN5060-8	S	S	S	G	D	D	D	D	Tape Reel

Note: Pin Assignment: G: Gate D: Drain S: Source

<p>UTT60N10MG-TA3-T</p>  <p>(1) Packing Type (2) Package Type (3) Green Package</p>	<p>(1) T: Tube, R: Tape Reel (2) TA3: TO-220, TF3: TO-220F, TM3: TO-251, TN3: TO-252, T47: TO-247, S08: SOP-8, K08-5060: DFN5060-8 (3) G: Halogen Free and Lead Free, L: Lead Free</p>
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## MARKING

Package	Marking
TO-220 TO-220F TO-247 TO-251 TO-252	 <p>UTC UTT 60N10M Lot Code → → → → → Date Code 1</p> <p>L: Lead Free G: Halogen Free Date Code</p>
SOP-8	 <p>UTC UTT 60N10M Lot Code → → → → → Date Code 1 2 3 4</p>
DFN5060-8	 <p>UTC UTT 60N10M Lot Code → → → → → Date Code</p>



### ■ ABSOLUTE MAXIMUM RATING (T<sub>C</sub> =25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V <sub>DSS</sub>	100	V
Gate-Source Voltage		V <sub>GSS</sub>	±20	V
Drain Current	Continuous	TO-220/TO-220F TO-251/TO-252	60	A
		SOP-8	30	A
		DFN5060-8	40	A
	Pulsed (Note 2)	TO-220/TO-220F TO-251/TO-252	100	A
		SOP-8	50	A
		DFN5060-8	67	A
Avalanche Current		I <sub>AS</sub>	20	A
Avalanche Energy (Note 3)		E <sub>AS</sub>	200	mJ
Power Dissipation	TO-220	P <sub>D</sub>	125	W
	TO-220F		30	W
	TO-247		312	W
	TO-251/TO-252		50	W
	SOP-8		6	W
	DFN5060-8		14	W
Junction Temperature		T <sub>J</sub>	-40 ~ +150	°C
Storage Temperature Range		T <sub>STG</sub>	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating: Pulse width limited by maximum junction temperature.

3. L=1mH, I<sub>AS</sub>=20A, V<sub>DD</sub>=25V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub> = 25°C

### ■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient	TO-220/TO-220F TO-247	θ <sub>JA</sub>	62.5	°C/W
	TO-251/TO-252		110	°C/W
	SOP-8		50	°C/W
	DFN5060-8		65	°C/W
	TO-220		1	°C/W
Junction to Case	TO-220F	θ <sub>JC</sub>	4.17	°C/W
	TO-247		0.4	°C/W
	TO-251/TO-252		2.5	°C/W
	SOP-8		20.8	°C/W
	DFN5060-8		8.93	°C/W

Note: Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

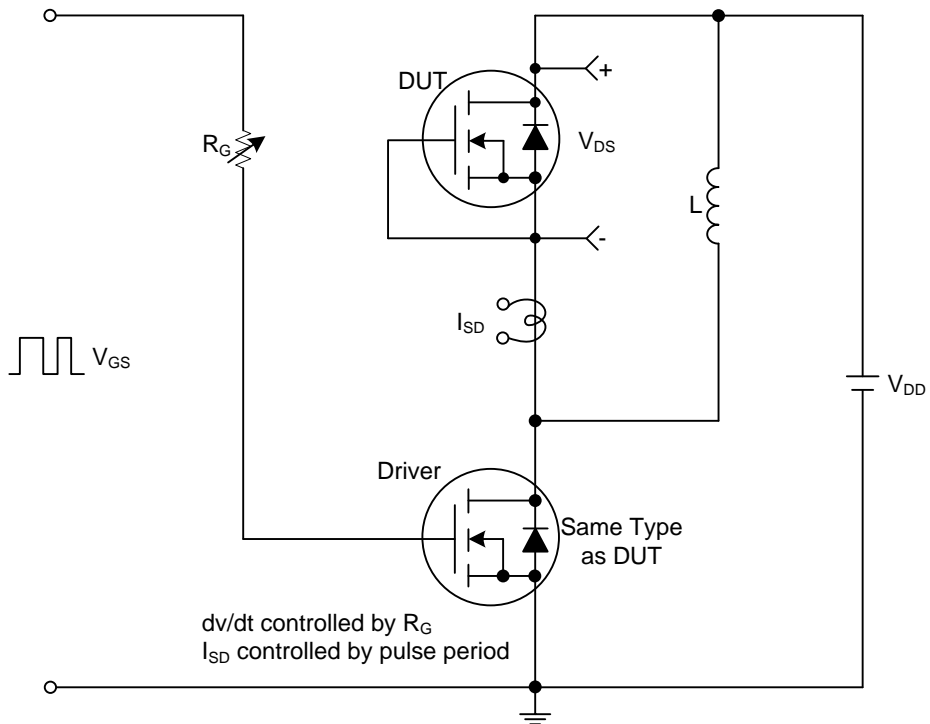
■ **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^\circ\text{C}$ , unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
<b>OFF CHARACTERISTICS</b>						
Drain-Source Breakdown Voltage	$BV_{DSS}$	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	100			V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS}=100\text{V}, V_{GS}=0\text{V}, T_J=25^\circ\text{C}$			1	$\mu\text{A}$
Gate-Source Leakage Current	Forward	$V_{GS}=+20\text{V}, V_{DS}=0\text{V}$ $V_{GS}=-20\text{V}, V_{DS}=0\text{V}$			+100	nA
	Reverse				-100	nA
<b>ON CHARACTERISTICS</b>						
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.0		3.0	V
Static Drain-Source On-State Resistance	$R_{DS(ON)}$	$V_{GS}=10\text{V}, I_D=30\text{A}$			18	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=15\text{A}$			25	$\text{m}\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS}=-10\text{V}, I_D=-20\text{A}$		30		S
<b>DYNAMIC PARAMETERS</b>						
Input Capacitance	$C_{ISS}$	$V_{GS}=0\text{V}, V_{DS}=25\text{V}, f=1.0\text{MHz}$		5500		pF
Output Capacitance	$C_{OSS}$			250		pF
Reverse Transfer Capacitance	$C_{RSS}$			160		pF
Gate Resistance	$R_G$		$V_{DS}=0\text{V}, f=1.0\text{MHz}$		1	
<b>SWITCHING PARAMETERS</b>						
Total Gate Charge (Note 1)	$Q_G$	$V_{DS}=80\text{V}, V_{GS}=10\text{V}, I_D=60\text{A}$ $I_G=1\text{mA}$ (Note1, 2)		100		nC
Gate to Source Charge	$Q_{GS}$			12		nC
Gate to Drain Charge	$Q_{GD}$			18		nC
Turn-on Delay Time (Note 1)	$t_{D(ON)}$	$V_{DS}=50\text{V}, V_{GS}=10\text{V}, I_D=60\text{A},$ $R_G=3\Omega$ (Note1, 2)		12		ns
Rise Time	$t_R$			17		ns
Turn-off Delay Time	$t_{D(OFF)}$			64		ns
Fall-Time	$t_F$			20		ns
<b>SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS</b>						
Maximum Body-Diode Continuous Current	$I_S$				60	A
Forward On Voltage (Note 1)	$V_{SD}$	$I_S=60\text{A}, V_{GS}=0\text{V}$			1.2	V
Reverse Recovery Time (Note 1)	$t_{rr}$	$I_S=30\text{A}, V_{GS}=0\text{V},$		100		ns
Reverse Recovery Charge	$Q_{rr}$	$di/dt=100\text{A}/\mu\text{s}$		210		nC

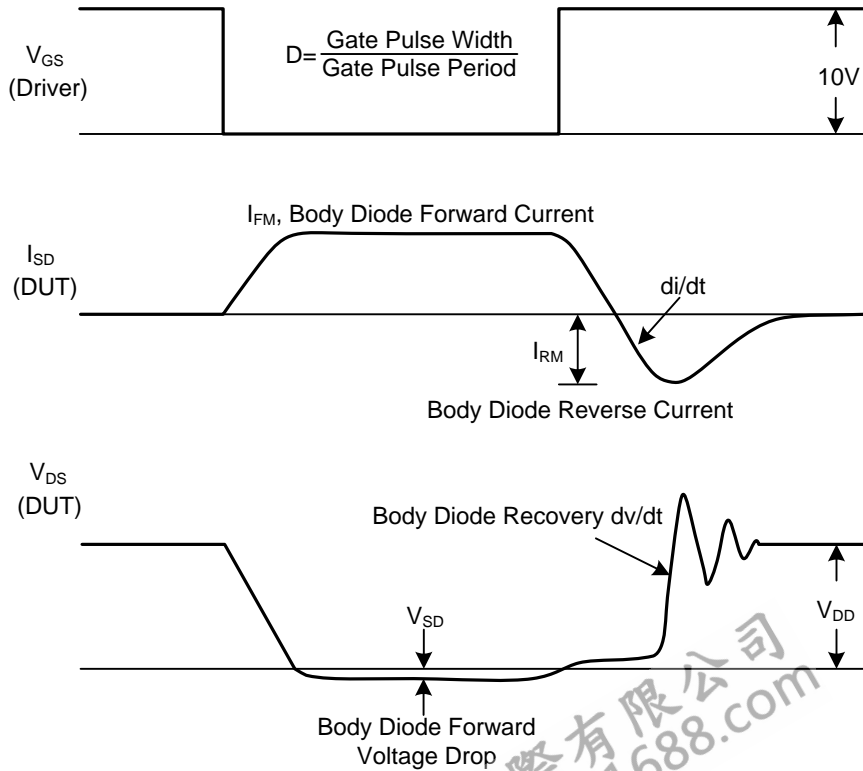
Notes: 1. Pulse Test: Pulse width  $\leq 300\mu\text{s}$ , Duty cycle  $\leq 2\%$ .

2. Essentially independent of operating temperature.

## TEST CIRCUITS AND WAVEFORMS



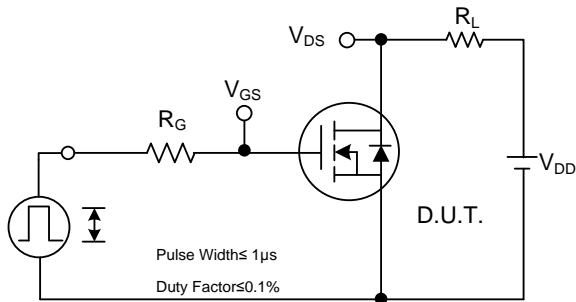
Peak Diode Recovery dv/dt Test Circuit



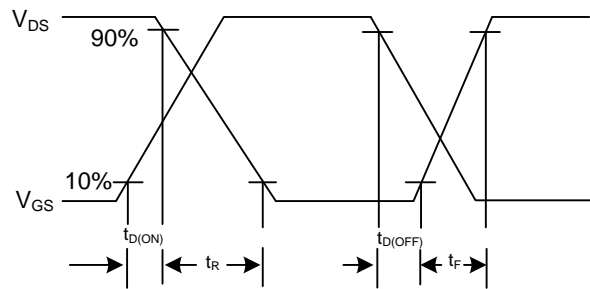
Peak Diode Recovery dv/dt Test Circuit and Waveforms

Peak Diode Recovery dv/dt Waveforms

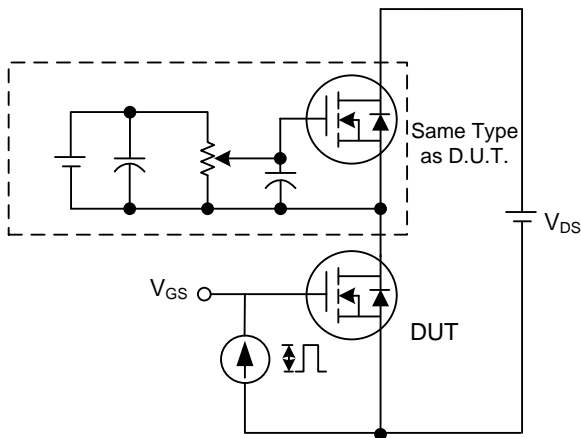
## TEST CIRCUITS AND WAVEFORMS



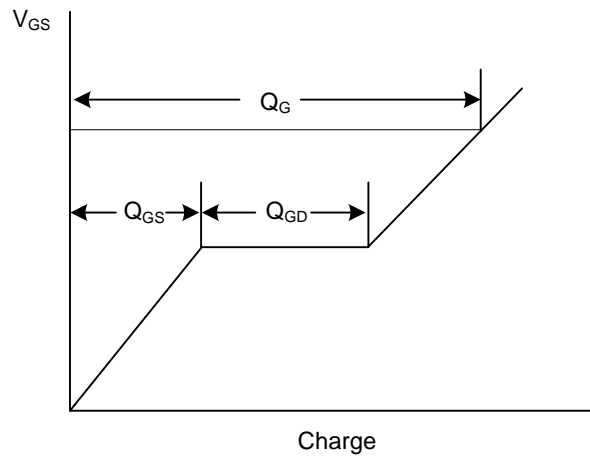
Switching Test Circuit



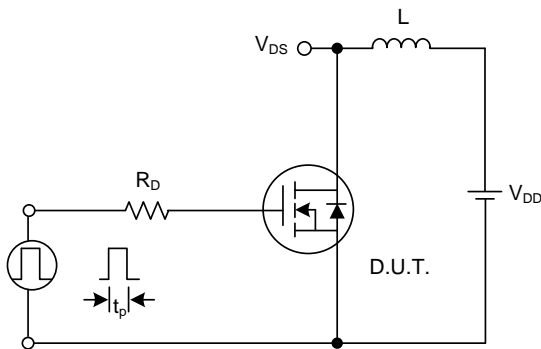
Switching Waveforms



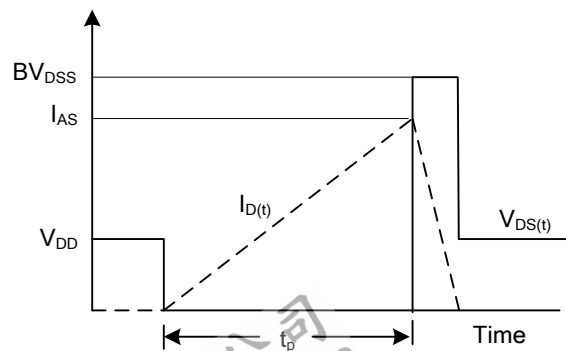
Gate Charge Test Circuit



Gate Charge Waveform

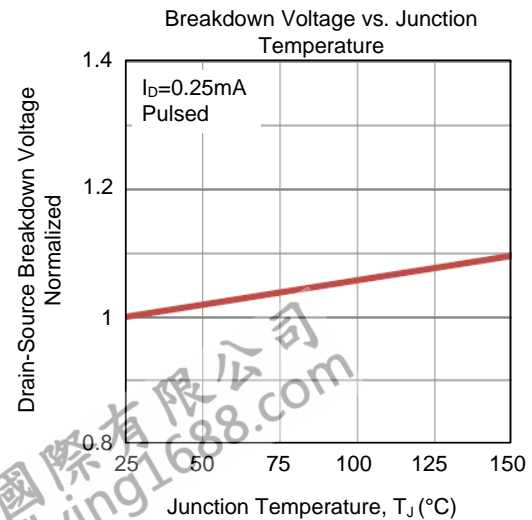
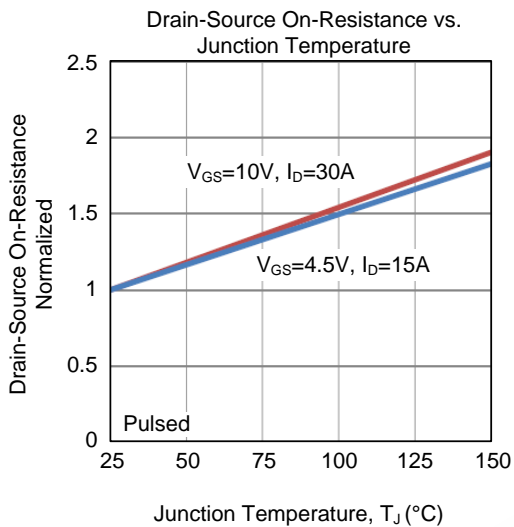
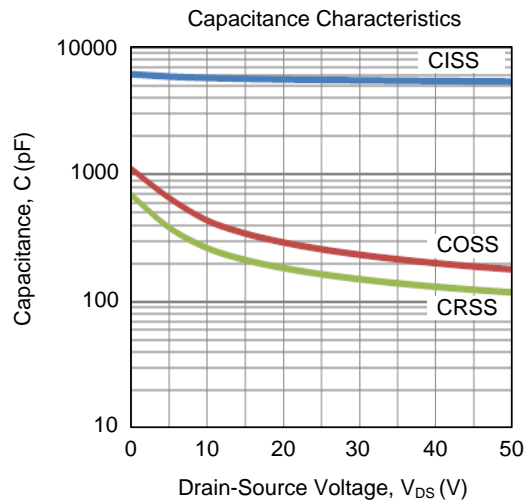
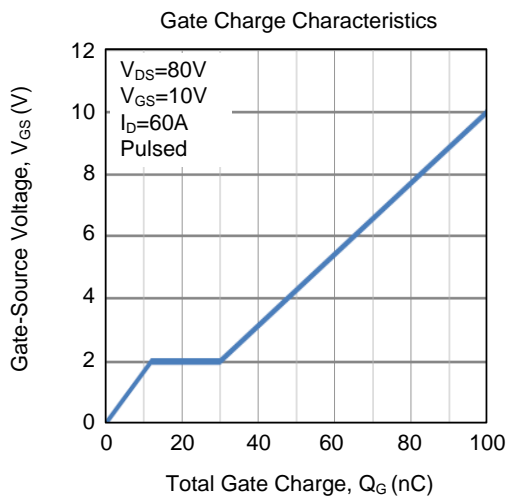
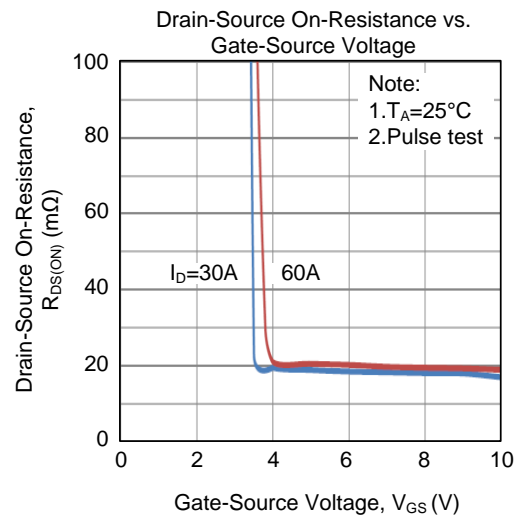
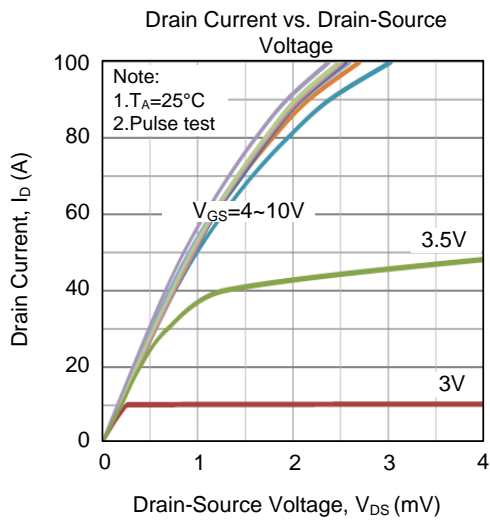


Unclamped Inductive Switching Test Circuit

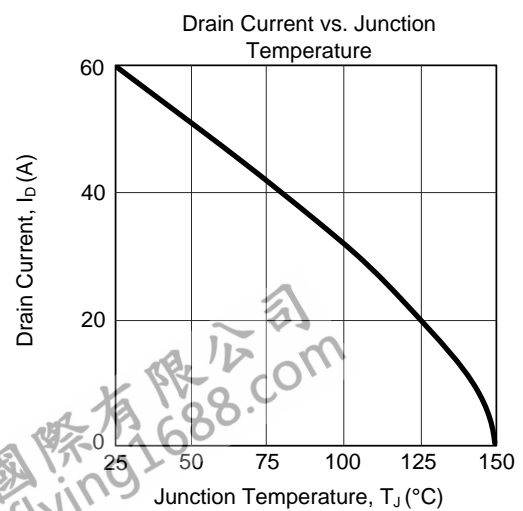
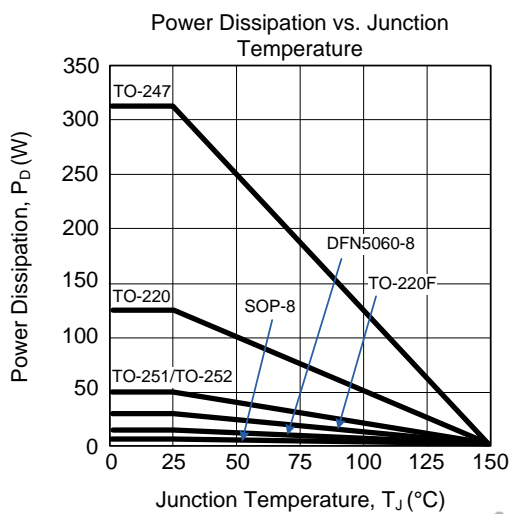
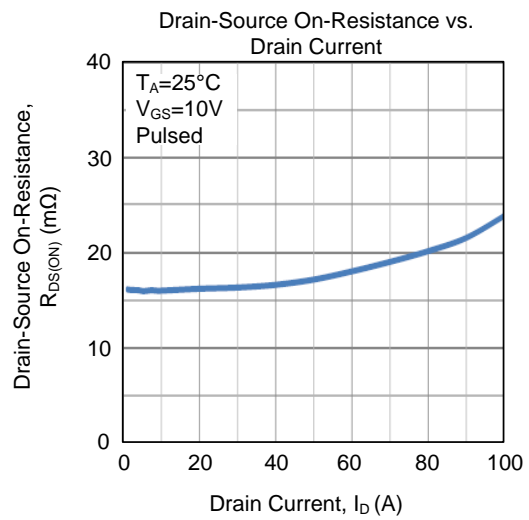
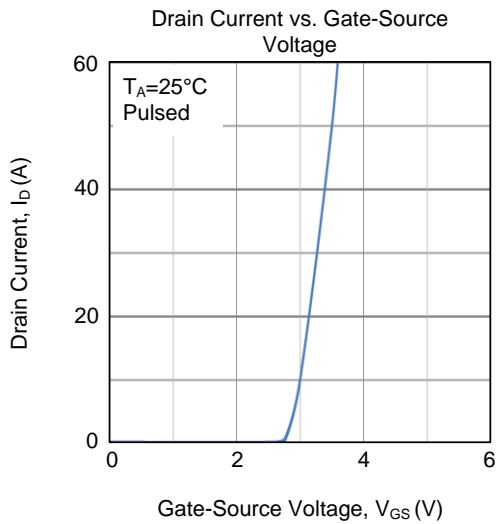
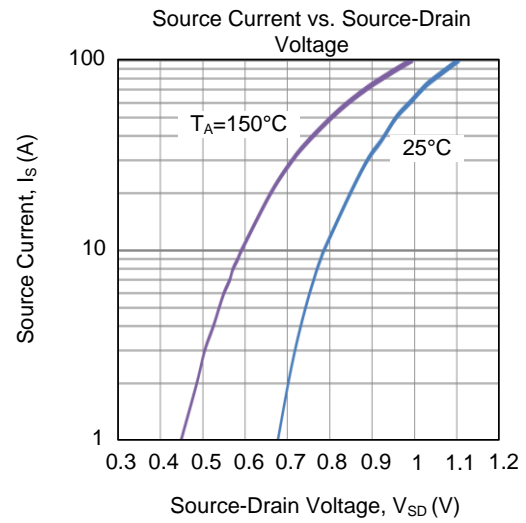
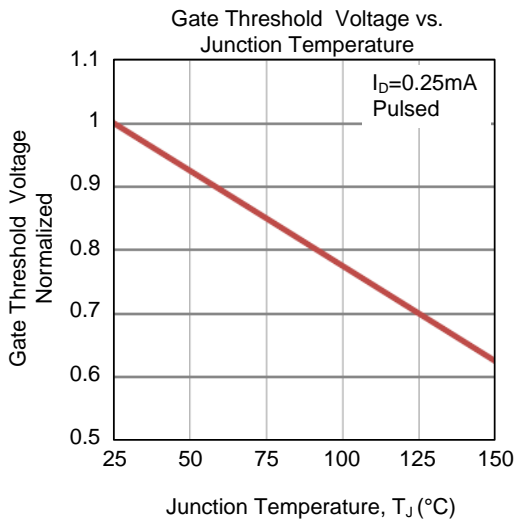


Unclamped Inductive Switching Waveforms

## TYPICAL CHARACTERISTICS

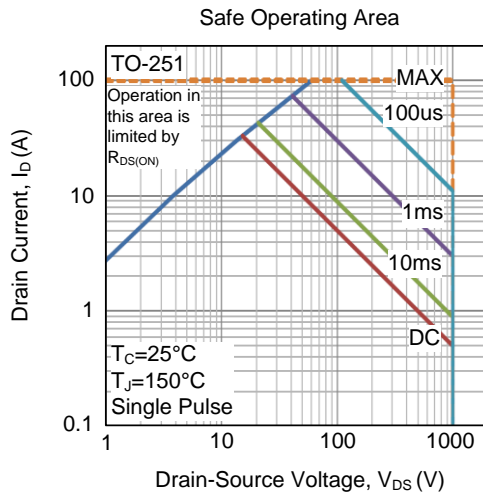


## TYPICAL CHARACTERISTICS (Cont.)





## ■ TYPICAL CHARACTERISTICS (Cont.)



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